

# N2600 Series High Precision Source Meter (SMU)



### **Product Introduction**

N2600 series is a digital source meter developed by NGI, which closely combines the functions of high-accuracy source and high-accuracy measurement. It integrates 5 functions (voltage source, current source, I/V/R measurement) in one instrument. The measurement range covers 200V to 1μV, 10A to 10pA, 200MΩ to 10μΩ. The maximum pulse output current can be up to 10A. The measurement resolution is 6½ digits. The basic accuracy can reach 100μV, 600pA, 300μΩ. N2600 series has built-in constant voltage source, constant current source, resistance measurement, sweep mode, signal generator, synchronous trigger, function calculator, etc., and provides PC application software for free. It can be widely used in characteristic analysis and production testing of components and modules in communication, semiconductor, computer, automotive and medical industries.

# **Application Fields**

- Nanomaterial and device
- Graphene
- Carbon nanotube
- Nanowire
- Semiconductor assembly test
- Diode, Zener diode, LED, laser diode
- BJT, MOSFET, SIC, GAN, etc.
- IC chip

#### Energy efficiency and lighting

- LED/AMOLED
- Photovoltaic/solar cell
- Battery, DC-DC converter







#### • Organic material and device

- Electronic ink
- Printed electronics
- Passive component, sensor
- Resistor, rheostat, thermistor, switch
- Photoelectric sensor, sensor
- Material property analysis
- Resistivity
- Hall effect







**Main Features** 

- 5 in 1 (voltage source, current source, I/V/R measurement)
- Wide measurement range, 200V to 1 $\mu$ V, 10A to 10pA, 200M $\Omega$  to 10 $\mu$  $\Omega$
- Supporting pulse mode, minimum pulse width 150µs <sup>[1]</sup>
- Basic accuracy up to 100µV, 600pA, 300µΩ
- Maximum sampling rate 100ksps
- Source and sink (4-quadrant) operation
- 2/4/6-wire resistance measurement
- Free PC application software, providing function calculator
- Supporting linear staircase sweep, logarithmic staircase sweep and custom sweep
- 4.3 inch LCD screen, simple operation interface, easy to use

Remark[1]: Only N2610-100-03 supports this function.

- SEQ test function and I-V characteristic analysis
- Supporting signal generator and square wave
- Digital I/O and external trigger control
- LAN port, RS232 interface
- Supporting SCPI protocol
- Front USB port, supporting screenshot storage





#### 5 in 1 (voltage source, current source, I/V/R measurement)

N2600 series adopts a standard ½ 19-inch 2U chassis. Integrating source and measure circuits into a compact standalone instrument greatly reduces test system development, setup and maintenance time, while saving test bench space and reducing the overall purchase cost.

The precision coupling feature of N2600 Series SMU offers many advantages over discrete instruments. While providing accurate output voltage and current sources, it can measure current, voltage and resistance, and has a high test response speed, which can protect the DUT from being damaged under occasional overload, thermal runaway, etc.



#### **I-V characteristics**

Usually, I-V characterization of a DUT requires the use of highly sensitive ammeter, voltmeter, voltage source, and current source. The process of programming, synchronizing, connecting, measuring, and analyzing each of these instruments is complex, time-consuming, and takes up excessive test bench space.

N2600 series can greatly simplify the test process and reduce test bench space occupation. N2600 provides 4-quadrant operation. When operating in 1st and 3rd quadrant, N2600 acts as a power source to output power to the DUT. When operating in 2nd and 4th quadrant, N2600 acts as a sink (load) to absorb energy. In source or sink mode, N2600 can measure voltage, current, and resistance, making it an ideal selection for I-V characterization of DUT, such as material research, electronics, semiconductor, etc.



### **Power envelope**

Different from traditional matrix power supply, under the same power, on N2600, users can choose high voltage and low current or low voltage and high current output according to actual needs. The source/sink limit of N2600 are also different by choosing different specifications.

N2600-020-01 source/sink limit: ±21V@±1.05A N2600-200-01 source/sink limit: ±21V@±1.05A ±210V@±105M N2610-100-03 source/sink limit: ±21V@±3.15A ±105V@±1.05A ±105V@±10.5A(pulse mode only)



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#### Various sweep modes

N2600 supports linear staircase sweep, logarithmic staircase sweep, custom sweep and built-in sweep. The sweep mode runs automatically after setting the functional relation and protection point, which greatly speeds up the test efficiency. The sweep can be set up to single-event or continuous operation, making N2600 ideal for I/V, I/R, V/I, and V/R characterization.

- Linear staircase sweep: sweep from start level to end level in equal linear steps
- Logarithmic staircase sweep: sweep on a log scale with a specified number of steps per decade
- Custom sweep: allow user-defined setting
- Built-in sweep: 100 settings are stored in the system for call.



#### 2/4/6-wire resistance measurement

N2600 SMU integrates a high-precision digital multimeter function, which not only supports high-precision voltage and current measurement, but also supports 2/4/6-wire resistance measurement, which is suitable for various test scenarios.

2-wire resistance measurement is suitable for test scenarios where the resistance of the test leads is much smaller than the resistance to be measured, regardless of the voltage drop loss caused by the test leads. 4-wire resistance measurement is suitable for measuring low-value resistances. N2600 SMU has an auto-correction function that eliminates test lead effects. 6-wire resistance measurement: When the measured resistance is connected in parallel with other resistances, the other resistances will shunt and affect the test. N2600 SMU uses 6-wire resistance measurement to enable in-situ measurement of resistors on the PCB.



#### Automation to improve production test efficiency

N2600 SMU provides high-precision voltage and current sources while making high-precision measurements, without changing connections or using additional devices, which greatly improves production test efficiency. At the same time to meet the throughput requirements of production applications, N2600 has many built-in functions to run complex test sequences without using the slow computer control or GPIB communication.

### **Big LCD screen**

N2600 SMU is equipped with a 4.3-inch LCD screen. Compared with traditional VFD screens, LCD screens have the advantages of low power consumption, small size and low radiation. At the same time, combined with professional interface design, N2600 is easy to use, and the readback display is intuitive and comprehensive.







SMU

# Remote control for easy system integration

**Product Dimension** 

NGI provides users with a free PC application software, which can meet the testing needs of various application scenarios. N2600 SMU is equipped with LAN port and RS232 interface, and supports SCPI/Modbus commands.



PC Application Software





NGI



# **Technical Data Sheet** (1)

Model	N2600-200-01							
Specification	200V/1A/20W							
Screen	LCD							
Channels	1CH							
Digits	6½							
Quadrant	4							
	Range	Setting Resolution	Setting Accura (23±5 C)	cy Readback Resolu		ution	tion Readback Accuracy (23±5°C)	
	200V	1mV	0.02%+20mV	1mV		0.02%+20mV		
Voltage	20V	100µV	0.02%+2mV		100µV		0.02%+2mV	
	2V	10µV	0.02%+200µV		10µV		0.02%+200µV	
	200mV	1µV	0.02%+100µV		1µV		0.02%+100µV	
Voltage Ripple Noise	<2mVrms(Typical) (10Hz~20MHz)							
	Range	Setting Resolution	(23±5 C)	Readback Resolu		tion $(23\pm5^{\circ})$		
	1A	10µA	0.05%+500µA		10µA		0.05%+500µA	
	100mA	1µA	0.02%+20µA		1µA		0.02%+20µA	
Current	10mA	100nA	0.02%+2µA		100nA		0.02%+2µA	
Current	1mA	10nA	0.02%+200nA		10nA		0.02%+200nA	
	100µA	1nA	0.02%+20nA		1nA		0.02%+20nA	
	10µA	100pA	0.02%+2nA		100pA		0.02%+2nA	
	1µA	10pA	0.02%+600pA		10pA		0.02%+600pA	
	Range	Readback Current	Range	Readb	ack Resolution	Rea	dback Accuracy	
	2Ω	1A		10μΩ		0.2%+0.0003Ω		
	20Ω	100mA		100μΩ		0.05%+0.003Ω		
	200Ω	10mA		1mΩ		0.05%+0.03Ω		
Resistance	2kΩ	1mA		10mΩ 0.		0.0	.05%+0.3Ω	
	20kΩ	100µA		100mΩ 0		0.0	).05%+3Ω	
	200kΩ	10µA		1Ω		0.0	0.05%+30Ω	
	2ΜΩ	1µA		10Ω		0.1	%+300Ω	
	20MΩ	1µA		100Ω		0.1%+2kΩ		
	200MΩ	100nA		1kΩ 0.7		0.7	%+20kΩ	
Load Regulation	Voltage:200mV range≤0.03%, other ranges≤0.01%			Current:1µA/1A range≤0.02%, other ranges≤0.01%				
Voltage Slew	20V@ 0.08V/µs±20% 200V@ 0.5V/µs±20%							
Current Slew	1A@0.12A/µs±20%			100mA@0.008A/µs±20%				
Source/Sink	- +21V@+1	+211/@+1.054			±210V@±105A			
Temperature Coefficient	10ppm/C ±210V@±105A							
Transient Response Time	≤30µs							
Maximum Sampling Rate	100ksps							
Output	Range	Typical Output Set	tling Time	Test Condition				
·	200V	<375us	-					
Voltage	20V	<195µs		10% to 90% voltage variation time under open-circuit & no-load condition				
Source	2V	<20µs						
	200mV	<20µs						
	1A	<10us						
	100mA	<20us						
Current	10mA	<15/10						
Source	1mA	<300us		10% to 90% current variation time under output				
Source	100	<1ma		short-circuit condition				
	100µA	< IIIIS						
	1.1.0	~5mg						
	iμA	~0IIIS						

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Model	N2600-200-01					
Protection	OVP, OCP, OTP, OPP					
Common Mode Voltage	250V DC					
Sweep	1ms step					
Auto Range	Yes					
Delay Measurement	Yes					
Poweroff Memory	Yes					
Protocol	SCPI/Modbus					
Interface	LAN/RS232					
AC Input	Single phase, 110/220V AC±10%, frequency 47Hz~63Hz					
Temperature	Operating temperature:0°C~40°C, storage temperature:-20°C~60°C					
Operating Environment	Altitude <2000m, relative humidity:5%~90%RH(non-condensing), atmospheric pressure:80~110kPa					
Net Weight	Approx.3kg					
Dimension	2U, 88.0(H)*214.0(W)*366.0(D)mm					

Note 1: For other specifications, please contact NGI. Note 2: All specifications are subject to change without notice.





# **Technical Data Sheet** (2)

Model	N2600-020-01						
Specification	20V/1A/20W						
Screen	LCD						
Channels	1CH						
Digits	6½						
Quadrant	4						
	Range	Setting Resolution	Setting Accuracy (23±5 C)		Readback Resolution		Readback Accuracy (23±5°C)
	20V	100µV	0.02%+2mV		100µV		0.02%+2mV
Voltage	2V	10µV	0.02%+200µV		10µV		0.02%+200µV
	200mV	1µV	0.02%+100µV		1μV		0.02%+100µV
Voltage Ripple Noise	<2mVrms(Typical) (10Hz~20MHz)						
	Range	Setting Resolution	Setting Accuracy (23±5 C)		Readback Resolution		Readback Accuracy (23±5 <sup>°</sup> C)
	1A	10µA	0.05%+500µA		10µA		0.05%+500µA
	100mA	1µA	0.02%+20µA		1μA		0.02%+20µA
Current	10mA	100nA	0.02%+2µA		100nA		0.02%+2µA
	1mA	10nA	0.02%+200nA		10nA		0.02%+200nA
	100µA	1nA	0.02%+20nA		1nA		0.02%+20nA
	10µA	100pA	0.02%+2nA		100pA		0.02%+2nA
	1µA	10pA	0.02%+600pA	рА 10рА			0.02%+600pA
	Range	Readback Current	Range	Readb	ack Resolution	Readback Accuracy	
	2Ω	1A		10μΩ		0.2%+0.0003Ω	
	20Ω	100mA		100μΩ		0.05%+0.003Ω	
	200Ω	10mA		1mΩ		0.05%+0.03Ω	
Resistance	2kΩ	1mA		10mΩ		0.05%+0.3Ω	
	20kΩ	100µA		100mΩ		0.05%+3Ω	
	200kΩ	10µA		1Ω		0.05%+30Ω	
	2ΜΩ	1µA		10Ω		0.1	%+300Ω
	20ΜΩ	1µA		100Ω		0.1%+2kΩ	
	200ΜΩ	100nA		1kΩ 0.7		%+20kΩ	
Load Regulation	ion Voltage:200mV range≤0.03%, other ranges≤0.01% Current:1µA/1A range≤0.02%, other ranges≤0.01%						
Voltage Slew	20V@ 0.08V/µs±20%						
Current Slew	1A@0.12A	/µs±20%					
Source/Sink Limit	±21V@±1.05A						
Coefficient	40ppm/ <sup>°</sup> C						
Response Time	e ≤30µs						
Sampling Rate	100ksps						
Output	Range	Typical Output Set	tling Time	Test Condition			
Voltage	20V	<195µs		10% to 90% voltage variation time under			
Source	2V	<20µs		open-circuit & no-load condition			
	200mV	<20µs					
	1A	<10µs					
	100mA	<20µs					
Current	10mA	<15µs		10% to 90% current variation time under output short-circuit condition			time under output
Source	1mA	<300µs					
	100µA	<1ms					
	10µA	<5ms					
	1µA	<5ms					





Model	N2600-020-01					
Protection	OVP, OCP, OTP, OPP					
Common Mode Voltage	250V DC					
Sweep	1ms step					
Auto Range	Yes					
Delay Measurement	Yes					
Poweroff Memory	Yes					
Protocol	SCPI/Modbus					
Interface	LAN/RS232					
AC Input	Single phase, 110/220V AC±10%, frequency 47Hz~63Hz					
Temperature	Operating temperature:0°C ~40°C, storage temperature:-20°C ~60°C					
Operating Environment	Altitude <2000m, relative humidity:5%~90%RH(non-condensing), atmospheric pressure:80~110kPa					
Net Weight	Approx.3kg					
Dimension	2U, 88.0(H)*214.0(W)*366.0(D)mm					

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Note 1: For other specifications, please contact NGI. Note 2: All specifications are subject to change without notice.





# **Technical Data Sheet** (3)

Model	N2610-100-03							
Specification	100V/3A/1	00W(pulse mode:1	000W)					
Screen	LCD	LCD						
Channels	1CH	1CH						
Digits	61⁄2							
Quadrant	4							
	Range	Setting Resolution	n Setting Accura (23±5℃)	icy F	Readback Resolution		Readback Accuracy (23±5°C)	
	100V	1mV	0.02%+12mV		1mV		0.015%+5mV	
Voltage	20V	100µV	0.02%+2.4mV	1	100µV		0.015%+1mV	
5	2V	10µV	0.02%+600µV	/	10µV		0.012%+300µV	
	200mV	1µV	0.02%+600µV	1	1µV		0.012%+300µV	
Voltage Ripple Noise	<sup>∋</sup> <2mVrms(Typical) (10Hz~20MHz)							
	Range	Setting Resolution	າ Setting Accura (23±5 ິ)	cy Readback Resolut		ution	$(23\pm5^{\circ}C)$	
	10A <sup>[1]</sup>	100µA	0.089%+5.9m	A 1	10µA		0.082%+1.71µA	
	3A	100µA	0.059%+2.8m	A 1	10µA		0.052%+1.71µA	
Current	1A	10µA	0.067%+900µ	A 1	10µA		0.06%+570µA	
Current	100mA	1µA	0.066%+20µA	. 1	lμA		0.055%+6µA	
	10mA	100nA	0.045%+2µA	1	00nA		0.035%+600nA	
	1mA	10nA	0.034%+200n	A 1	l0nA		0.027%+60nA	
	100µA	1nA	0.031%+20nA	. 1	1nA		0.025%+6nA	
	10µA	100pA	0.033%+2nA	1	00pA		0.027%+700pA	
	Range	Readback Curren	back Current Range		Readback Resolution		Readback Accuracy	
	2Ω	1A		10μΩ		0.1	0.17%+0.0003Ω	
	20Ω	100mA		100μΩ		0.1	0.10%+0.003Ω	
	200Ω	10mA		1mΩ		0.0	0.08%+0.03Ω	
Resistance	2kΩ	1mA		10mΩ		0.0	0.07%+0.3Ω	
	20kΩ	100µA		100mΩ		0.06%+3Ω		
	200kΩ	10µA		1Ω		0.0	0.07%+30Ω	
	2ΜΩ	1µA		10Ω		0.1	1%+300Ω	
	20ΜΩ	1μΑ		100Ω 0.1		0.1 <sup>,</sup>	1%+1kΩ	
Load Regulation	Voltage:each range* 0.01%+100µV			Current:each range* 0.01%+100pA				
Line Regulation	Voltage:each range* 0.01%			Current:each range* 0.01%				
Voltage Slew	20V@0.08V/µs±30% 100V@0.25V/µs±20%							
Source/Sink Limit	±3.15A@±	±1.05A@±105₩		±10.5A@±105V()			oulse mode only)	
Limit	±21V@±3.	15A	±105A@±1.05V	±105A@±10.5\			oulse mode only)	
Temperature Coefficient	40ppm/C							
Transient Response Time	≤30µs							
Sampling Rate	100ksps							
Output	Range	Typical Output Settling Time		Test Condition				
	100V <375µs							
Voltage	20V	<195µs		10% to 90% voltage variation time under				
Source	2V	<20µs		open-circuit & no-load condition				
	200mV	<20µs						
	3A	<375µs						
	1A	<195µs						
Current	100mA	<20µs		10% to 90% current variation time under output				
Source	10mA	<20µs		short-circuit condition				
	1mA	<20µs						
	100µA	<20µs						
	10µA	<20µs						

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Model	N2610-100-03					
Protection	OVP, OCP, OTP, OPP					
Common Mode Voltage	125V DC					
Sweep	1ms step					
Auto Range	Yes					
Delay Measurement	Yes					
Poweroff Memory	Yes					
Protocol	SCPI/Modbus					
Interface	LAN/RS232					
AC Input	Single phase, 110/220V AC±10%, frequency 47Hz~63Hz					
Temperature	Operating temperature:0°C~40°C, storage temperature:-20°C~60°C					
Operating Environment	Altitude <2000m, relative humidity:5%~90%RH(non-condensing), atmospheric pressure:80~110kPa					
Net Weight	Approx.3kg					
Dimension	2U, 88.0(H)*214.0(W)*366.0(D)mm					

#### Remark **[1]** : 10A range is only for pulse mode.

Additional pulse mode source specifications: Pulse width definition: Pulse width refers to the time from 90% rising edge to 90% falling edge. Minimum pulse programming resolution:  $10\mu$ s Pulse width programming accuracy:  $\pm 5\mu$ s Minimum pulse width:  $150\mu$ s Maximum pulse width: 2.5ms for 10A range, 5ms for other ranges Pulse width jitter:  $50\mu$ s Maximum duty cycle: 8% for 10A range, 100% for other ranges

Note 1: For other specifications, please contact NGI. Note 2: All specifications are subject to change without notice.

